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-	1259	<pre>((((((((((((simulat\$4 or model\$3 or emulat\$4) and circuit) and volt\$4 and current and (resist\$4 or conduct\$4)) and (line\$5 or nonline\$5 or non-lin\$5)) and (time or timing) and (((wire or wiring) same (connect\$4 or intersect\$4)))) and (electron or particle)) and state) and transfer\$5) and (rule or law or guide or standard)) and source) and (computer or cpu or processor or microprocessor)</pre>	USPAT; US-PGPUB; IBM_TDB	2002/12/20 12:08
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_	2142	<pre>((simulat\$4 and circuit).ab.) and (volt\$4 or current or (resist\$4 or conduct\$5 or imped\$4))</pre>	USPAT; US-PGPUB; IBM_TDB	2002/12/20 12:19
_	1049	((simulat\$4 and circuit).ab.) and (volt\$4 and current and (resist\$4 or conduct\$5 or imped\$4))	USPAT; US-PGPUB; IBM_TDB	2002/12/20
_	385	<pre>(((simulat\$4 and circuit).ab.) and (volt\$4 and current and (resist\$4 or conduct\$5 or imped\$4))) and transfer\$5</pre>	USPAT; US-PGPUB; IBM_TDB	2002/12/20 12:19
_	303	<pre>((((simulat\$4 and circuit).ab.) and (volt\$4 and current and (resist\$4 or conduct\$5 or imped\$4))) and transfer\$5) and state</pre>	USPAT; US-PGPUB; IBM_TDB	2002/12/20

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